ISO 11505:2025-06 (E)

Surface chemical analysis - General procedures for quantitative compositional depth profiling by glow discharge optical emission spectrometry

Contents

Page

Foreword ..... **v**

1 Scope **1**

2 Normative references **1**

3 Terms and definitions **1**

4 Principle **1**

5 Apparatus **2**
5.1 Glow discharge optical emission spectrometer 2
5.1.1 General 2
5.1.2 Selection of spectral lines 2
5.1.3 Selection of glow discharge source type 2

6 Adjusting the glow discharge spectrometer system settings **3**
6.1 General 3
6.2 Setting the discharge parameters of a DC source 4
6.2.1 Constant applied current and voltage 4
6.2.2 Constant applied current and pressure 5
6.2.3 Constant applied voltage and pressure 5
6.3 Setting the discharge parameters of an RF source 6
6.3.1 Constant applied power and pressure 6
6.3.2 Constant applied power and DC bias voltage 6
6.3.3 Constant effective power and RF voltage 7
6.4 Minimum performance requirements 7
6.4.1 General 7
6.4.2 Control of lamp cleanliness and start-up performance 7
6.4.3 Minimum repeatabilitry 9
6.4.4 Detection limit 9

7 Sampling **11**

8 Calibration **11**
8.1 General 11
8.2 Calibration specimens 11
8.2.1 General 11
8.2.2 Low-alloy iron or steel specimens 12
8.2.3 Stainless-steel specimens 12
8.2.4 High-oxygen specimens 12
8.2.5 High-carbon specimens 12
8.2.6 High-nitrogen specimens 12
8.2.7 High-purity copper specimens 12
8.2.8 High-purity zinc specimens 13
8.3 Validation specimens 13
8.4 Determination of the sputtering rate of calibration and validation specimens 13
8.5 Emission intensity measurements of calibration specimens 14
8.6 Calculation of calibration formulae 14
8.7 Validation of the calibration 14
8.7.1 General 14
8.7.2 Checking analytical accuracy using bulk reference materials 15
8.7.3 Checking analytical accuracy using surface layer reference materials 15
8.8 Verification and drift correction 15

9 Analysis of test specimens **16**
9.1 Adjusting discharge parameters 16
9.2 Setting of measuring time and data acquisition rate 16
9.3 Quantifying depth profiles of test specimens 16
10 Expression of results **16**
10.1 Expression of quantitative depth profile 16
10.2 Determination of total coating mass per unit area 17
10.3 Determination of average mass fractions 18
11 Precision **18**
12 Test report **18**
Annex A (normative) **Calculation of calibration constants and quantitative evaluation of depth profiles** **19**
Annex B (informative) **Suggested spectral lines for determination of given elements** **32**
Bibliography **34**